

Fab Transition Strategy

Next Generation Factory Vision from 300mm to 450mm

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450mm Program Manager

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Agenda

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Fab Transition Strategy October 25, 3:00 – 6:00pm

- **3:00 – 3:10 Introduction and Overview – Tom Abell**
- **3:10 – 3:30 Next Generation Factory Vision – Tom Abell**
- **3:30 – 4:00 300mm Projects – Brad Van Eck**
 - Overview of 300mm projects supporting Next Generation Factory Vision
- **4:00 – 4:40 450mm Transition Program – Tom Abell**
 - 450mm Transition Strategy Program
 - 450mm Silicon Readiness
 - 450mm Interoperability Test Bed
 - 450mm Guidelines and Standards
- **4:40 – 5:00 Questions & Answers**
- **5:00 – 6:00 NGF/450mm interactive session**
 - **in Live Oak Room**

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Introduction and Overview

**Tom Abell
450mm Program Manager**

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Background

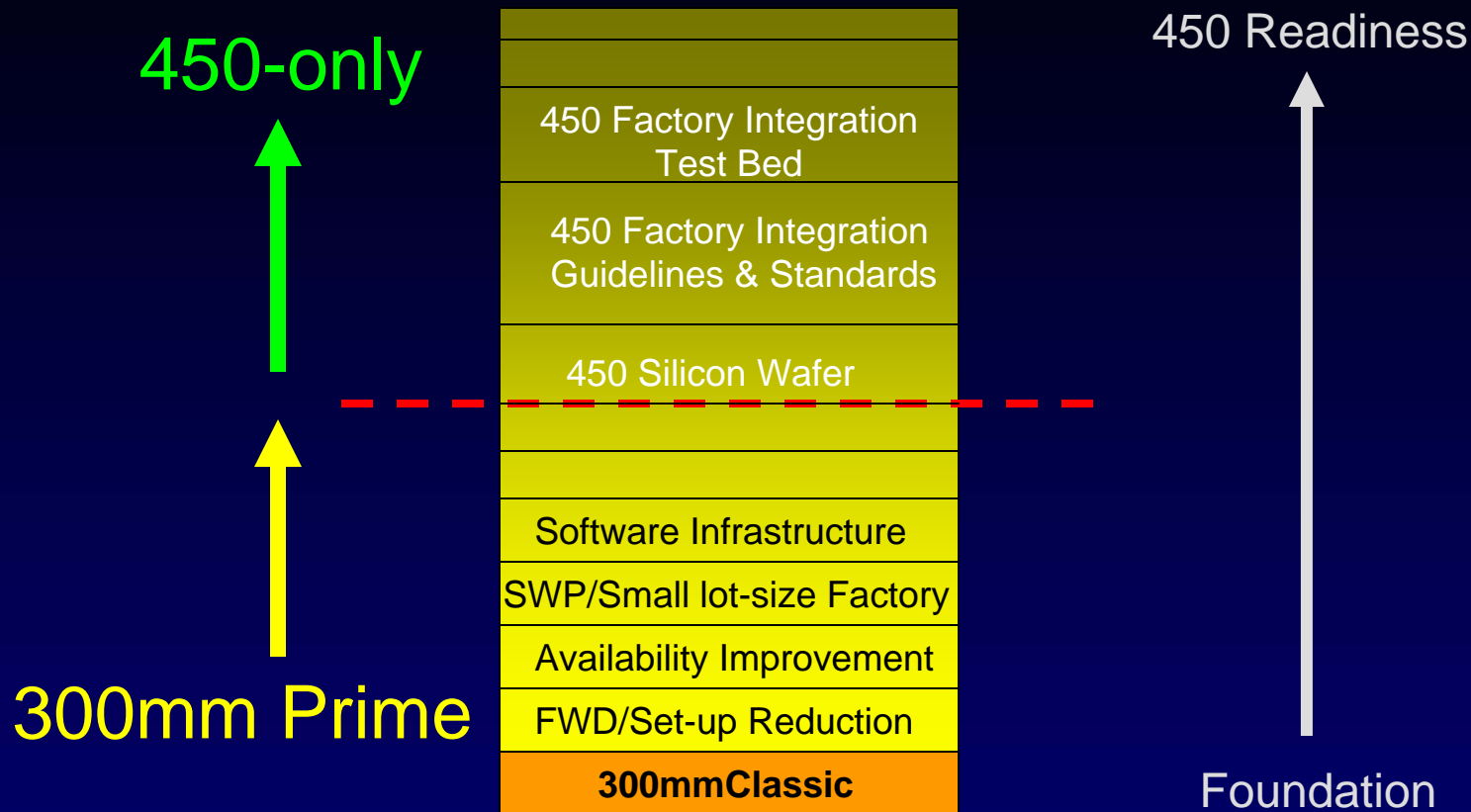
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- **ISMI member companies concur that major improvements in productivity are needed to sustain industry growth**
- **Significant changes in business conditions and business needs have revealed limitations in existing 300mm designs**
- **ISMI is investigating various paths to achieve significantly higher manufacturing productivity in the near- and far-future**

Perspective on ISMI Direction

- ISMI has developed a comprehensive strategy for near- and long-term productivity improvements
 - Next Generation Factory Vision and Guidelines covers the continuum of existing and future fabs from 300mm to 450mm
- An analysis of potential 300mm improvements shows 300mm Prime has cycle time opportunity but falls short of the traditional cost reduction required to stay on Moore's Law.
 - Metric goal: 30% cost reduction and 50% cycle time improvement
 - The financial benefit of cycle time reduction is difficult to quantify for different business models
 - Faster new product introduction, time to money, faster product delivery to customers
- ISMI has developed a complementary forward-compatible approach of 300mm Prime to 450mm
 - Addresses the needs of our various member constituencies
 - Attempts to minimize the R&D expenditure by the industry
 - **Efficient use of industry resources is key**

Next Generation Factory Vision Realization



- ISMI is moving forward with complementary forward-compatible paths for 300mm Prime and 450mm
 - Realization of 450mm is built upon coordinated improvements from 300mmPrime and 450-only activities to efficiently utilize industry resources
- Collaboration is a critical success factor: Inside and Outside ISMI

ISMI Perspective on 300mm Prime

- ISMI plans to pursue 300mm improvements that offer near-term productivity benefits in cycle time and cost reduction. This includes future optimized high productivity factories.
 - Initial focus areas include:
 - Next Generation Factory Realization Project
 - First Wafer Delay/Set-up Reduction
 - Predictive Preventative Maintenance
 - Equipment Data Quality
 - Factory for Small Lot Size
 - Production equipment reliability is a key opportunity for continuous improvement

ISMI Perspective on 450mm

- ISMI will initiate a 450mm Program dedicated to moving ahead with 450mm industry capability.
 - New mission
 - New structure
- ISMI plans to pursue in 2008:
 - Availability of 450mm silicon wafers
 - 450mm Factory Integration Guidelines & Standards
 - Creation of a 450mm Factory Integration Test Bed
 - Interoperability testing of prototype automation and equipment interfaces

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Next Generation Factory Vision

Tom Abell
450mm Program Manager

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Next Generation ISMI Factory Vision Themes

- Categories and boundaries for guidelines and standards

- 1. Process equipment shall be designed with an emphasis on elimination of all equipment-driven processing delays and per-lot overhead (including multi-lot batching)**
 - Enables rapid lot-to-lot setup/changeover at a competitive Cost of Ownership that is independent of lot size, with no negative impact to reliability
- 2. Process equipment and their supporting systems shall be designed to enable the realization of near-zero variability maintenance**
- 3. Next-generation equipment shall realize a significant reduction in the time required to install and qualify new toolsets, and shall be designed to reduce utilities and non-product wafer consumption.**
- 4. Process equipment shall have the ability to maintain continuous, real-time communication with host systems**
 - *Includes all tool-generated messaging (down to wafer level data), via standardized messaging formats and open architecture protocols.*
- 5. Flexible physical interfaces and wafer carriers, and high-speed, low variability AMHS that can cost-effectively support multiple operational models (including the potential for small-lot manufacturing)**
 - *Required to enable best-achievable equipment utilizations and yield*

 Process Equipment Themes

 Communication/Controls Themes

 Carriers/AMHS Themes

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“19 Point” Guidelines to enable Next Generation Factory Vision

1. **Maximum 450mm carrier capacity and specification for early prototypes**
2. **Front Opening 450mm wafer carriers**
3. **Carriers Designed for efficient Purging with standardized purge locations**
4. **MHS Design to assume infrequent, anomaly manual handling only**
5. **Design allowing Automated reticle transport**
6. **Standardized interfaces - equipment mainframe:process chambers**
7. **Standardized locations for low-cost buffers on tools (beyond loadports)**
8. **Equipment to be Predictive Maintenance friendly**
9. **Equipment maintenance and operation in parallel**
10. **“Smart Idle” mode for equipment**
11. **Facility adaptor plates**
12. **Equipment First wafer delay reduction**
13. **Single Wafer or Mini-batch (vs. Batch) processing tools**
14. **Equipment design for flexible capacity increments**
15. **Enable Continuous processing of material**
16. **Wafer-level instruction at any time before processing**
17. **Single Point of Control for factory system command/control**
18. **Equipment to provide data to enable external monitoring**
19. **Carrier:Slot integrity flexibility**

**Carriers
and AMHS**

**Equipment
Design**

**Equipment
Controls**

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ISMI Guideline Development Priorities

300mm

- Elimination of First Wafer Delay (#12) is the top priority guideline for 300mm NGF
- Predictive Maintenance (#8), Ability to perform Maintenance and Operations Simultaneously (#9), Continuous Operation (#15), and Equipment Engineering Data for Monitoring (#18) are important and with high benefit.

450mm

- Front-opening, 25 wafer, purge-able carriers (#'s1-3) are top priority for 450mm
- Elimination of First Wafer Delay (#12) is important and with high benefit
- 300mm equipment improvements and learnings expected to be applicable to 450mm

Summary

- **300mm Prime has cycle time opportunities but does not sufficiently address cost reduction needs to replace 450mm transition**
- **ISMI has developed a complementary forward-compatible approach of 300mm to 450mm**
 - Addresses the needs of our various member constituencies
 - Attempts to minimize the R&D expenditure by the industry
 - Efficient use of industry resources is key
- **Implications to ISMI programs**
 - **Initiate tangible 450mm activities to address long-term fundamental cost reduction**
 - *Cycle time also important for 450mm*
 - **Pursue 300mm improvements to enable significant near-term cycle time and cost reduction efforts**
 - **Initial 2008 activities efficiently guide two supplier groups**
 - **300mmPrime: Process & Metrology Equipment**
 - **450mm: Silicon & Factory Integration**

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Background

**300mm Prime
Analysis
and
Next Steps**

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300mm Transition Lessons Learned

- Industry coordination is crucial; early engagement of equipment and materials manufacturers
 - Determine fab architecture
 - Develop standards at the appropriate time
 - Consider bridge tools
- Support multiple leading-edge business models
 - High-volume/low-mix, High-volume/high-mix, etc.
- Assess business and economic models
 - Analyze cost, risk, benefit/ROI
- Continuously evaluate and adjust, including:
 - Impact of technology on timing
 - Market and industry dynamics

ISMI 450mm Program Objectives

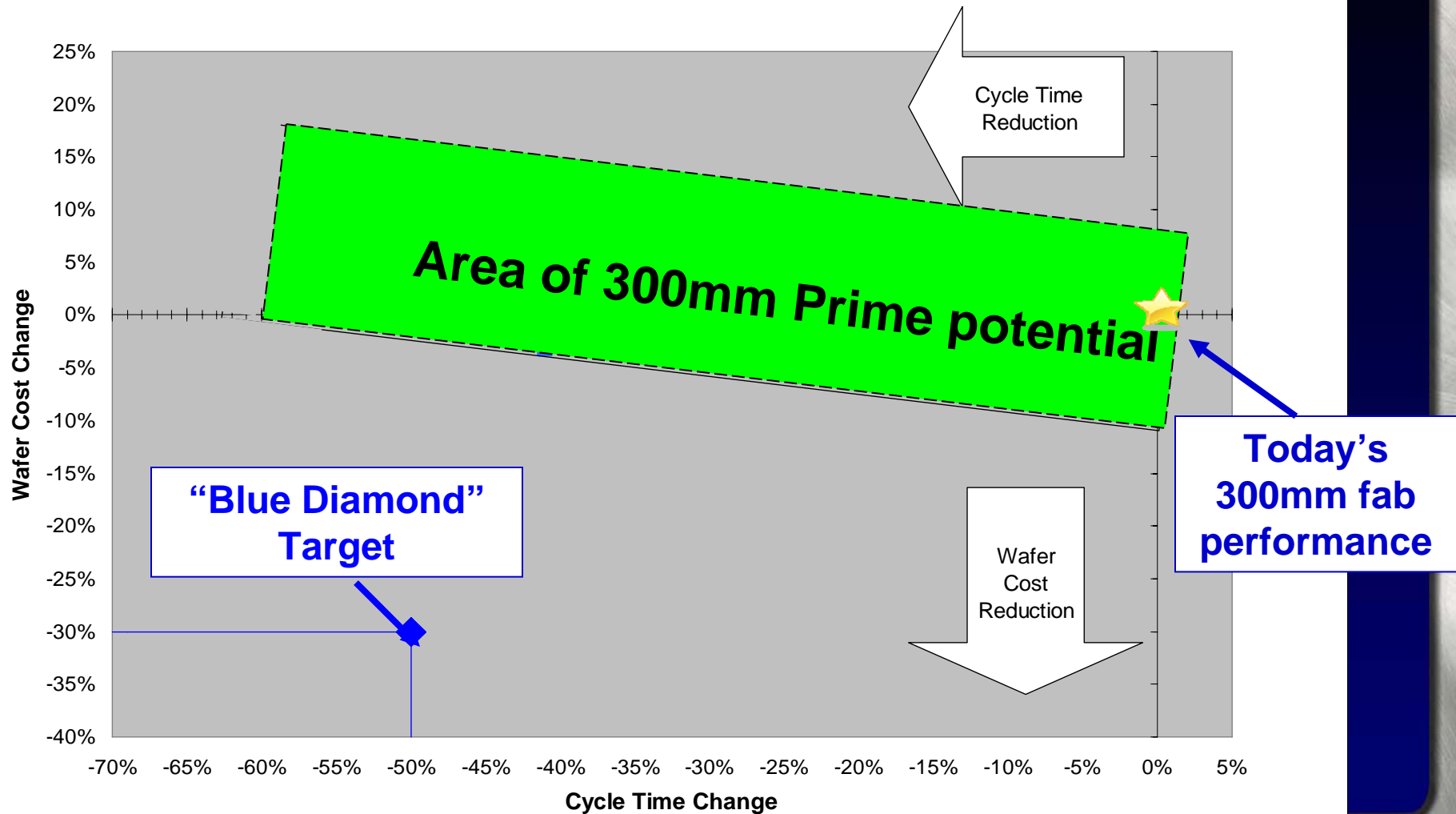
- Perform research, modeling, analysis and industry communication to support the transition strategy for 450mm.
- Focus on creating a cost-effective 450mm wafer size transition by **defining and incorporating a 300mm next generation factory (300mmPrime) as the bridge.**

300mmPrime is a set of 300mm factory and equipment designs focused on improving productivity for the next generation factory that has the capability of being scaled to 450mm

“Blue Diamond” Background

- 30% reduction in cost per area and 50% reduction in cycle time were set as the targets for 300mm Prime or 450mm in 2Q06
- Analysis of 300mm Prime potential against targets was decided in 3Q06 for completion by 2Q07
 - Determine whether 300mm Prime can be expected to deliver 30% cost reduction and 50% cycle time (Blue Diamond Analysis)
 - 450mm could move out to an intermediate timeframe based on expected benefit of 300mm Prime
 - OR
 - Accelerate 450mm planning and development
- Actions on 300mm Prime analysis since SEMICON West 2006
 - >130 full factory dynamic simulations for benefit analysis
 - Static factory and economic modeling
 - ROI on improvement options (cost vs. benefit)
 - Development of Next Generation Factory Vision as a unified 450mm / 300mm Prime strategy
 - Development of 19 Point Guidelines
 - Discussion/collaboration with SEMI and the industry during development process

300mm Prime - Cycle Time vs. Wafer Cost View



- Best-case 300mm Prime wafer cost savings modeled are <10%
- Cycle time reductions >50% modeled but may drive higher wafer cost

Simulation Background and Modeling Definitions

- **Simulation Software – AutoSched AP (ASAP), version 9.0.1, Build 103 – Discrete Event Simulator**
 - Use Semiconductor Extension
- Reference models (baseline 300mm Classic) were used to measure relative changes with each scenario to limit sources of error
- The Equipment Utilization / Equipment Availability (U/A) used as measure of factory loading and identifies equipment constraints to the process
- **Cascading: The ability many semiconductor equipment possess to allow the process start of multiple sequential wafers (and lots) before previously started wafers finish processing**
 - This capability can provide faster effective equipment run rates, thereby reducing the number of equipment required
 - Implemented by different approaches (e.g., multiple chambers, multiple stages, etc.)
 - To provide cascading in the simulator two ASAP features were used:
 - Part Interval - to simulated time between process start of wafers for cascading
 - Minimum Queue and Minimum Run – to facilitate longer cascades
- **“Extreme” Equipment Improvement Cases: These use scenario limits of First Wafer Delay (FWD), Setup, and Equipment Availability improvements**
 - FWD and Setup: 50% maximum reduction
 - Equipment Availability: 10% maximum increase (limited by International Technology Roadmap for Semiconductors “Red” Targets)
 - ITRS Red Targets = 2010 and later: 98% for Metrology Equipment, 95% for Process Equipment
- **High-Mix model has a larger percentage of wafer starts on shorter, older technology flows compared to leading edge low-mix flows**

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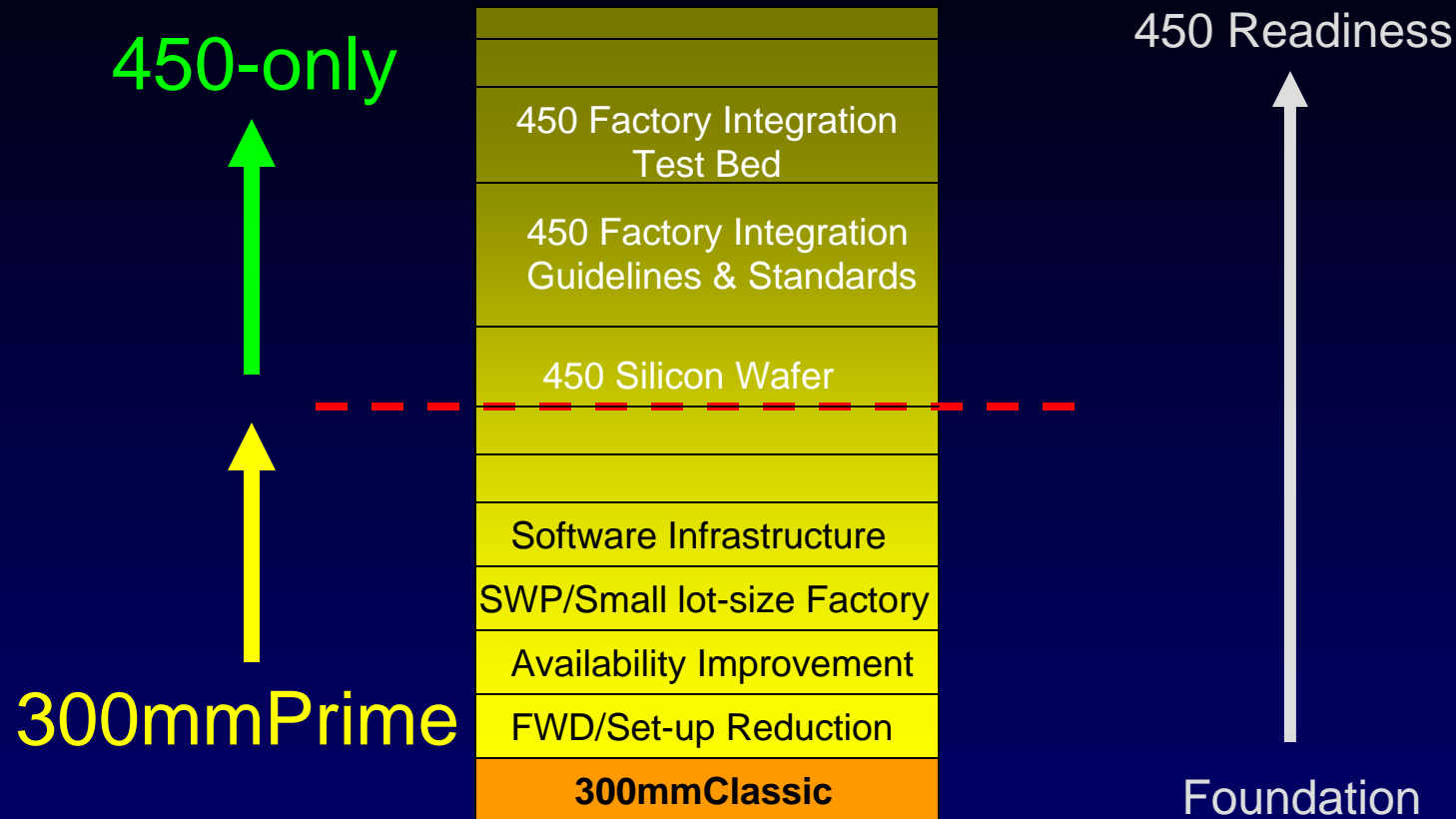
300mm Projects

**Brad Van Eck
FP Program Manager**

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Next Generation Factory Vision Realization



- ISMI is moving forward with both complementary forward-compatible paths for 300mmPrime as well as 300mm continuous improvement projects
- **Collaboration is a critical success factor: Inside and Outside ISMI**

ISMI Perspective on 300mm Prime

- ISMI plans to pursue 300mm improvements that offer near-term productivity benefits in cycle time and cost reduction. This includes future optimized high productivity factories.
 - Initial focus areas include:
 - Next Generation Factory Realization
 - First Wafer Delay/Set-up Reduction
 - Predictive Preventative Maintenance
 - Equipment Data Quality
 - Factory for Small Lot Size

ISMI 300mm Projects

- Next Generation Factory Realization Project

Objective : Develop a member company consensus of the critical equipment and factory level attributes and capabilities for Next Generation Factory (NGF)

- **Develop member company consensus of key NGF attributes**
- **Prioritize equipment/factory productivity opportunities**
- **Communicate consensus prioritization to suppliers**
- **Identify guidelines and SEMI standards required for NGF**
- **Develop productivity and cycle time metrics, targets, and timelines**
- **Perform benefit analyses (ROI) and simulation**
- **Develop strategy and engage suppliers in the delivery of NGF solutions**

ISMI 300mm Projects

- First Wafer Delay (FWD)/Setup Reduction

Objective : Reduction in the time between the delivery of a lot to a process tool and the time the first wafer begins processing

- Member company consensus of the tools that offer the greatest potential improvement
 - Pareto tools with longest FWD and Setup Delays
- Supplier engagement to identify root causes and development of improvement plans
- Target solutions that are economically viable

ISMI 300mm Projects

- Predictive, Preventative Maintenance (PPM)

Objective : Establish member company requirements, guidelines, and feasibility for the use of data to improve equipment availability and productivity through PPM

- Define member company requirements for both on-board and off-tool equipment PPM capabilities
- Define factory and equipment data required for PPM
- Engage equipment and software suppliers to implement and demonstrate selected PPM capabilities
- Champion and promote the adoption and implementation of PPM methods for the industry

ISMI 300mm Projects

- Equipment Data Quality

Objective : Establish member company requirements, guidelines, and best practices for availability/delivery of high quality data. Identify, select, and address top issues

- Define member company consensus requirements, scenarios, methods, and best practices
- Champion a data quality SEMI standard
- Develop data quality evaluation method
- Demonstrate selected supplier data quality improvements
- Demonstrate benefits of fab-wide time synchronization
- Educate industry to accelerate the adoption of data quality / time synchronization requirements

ISMI 300mm Projects

- Factory for Small Lot Size

Objective : Define the equipment and manufacturing systems impacts, capabilities, user requirements, member company consensus guidelines, standards, usage scenarios and test criteria required to enable small lot size for hi-mix or accelerated Cycle Time factories

- Establish consensus vision/requirements for small lot size factory: equipment, transport, factory systems, operations
- Create fab behavior models to identify and prioritize system wide impacts and opportunities
- Engage in feasibility studies, prototypes, and pilots for the challenge points including the creation of a test bed virtual fab
- SEMI standards development as required

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ISMI 450mm Program Update

Tom Abell
450mm Program Manager

October 2007

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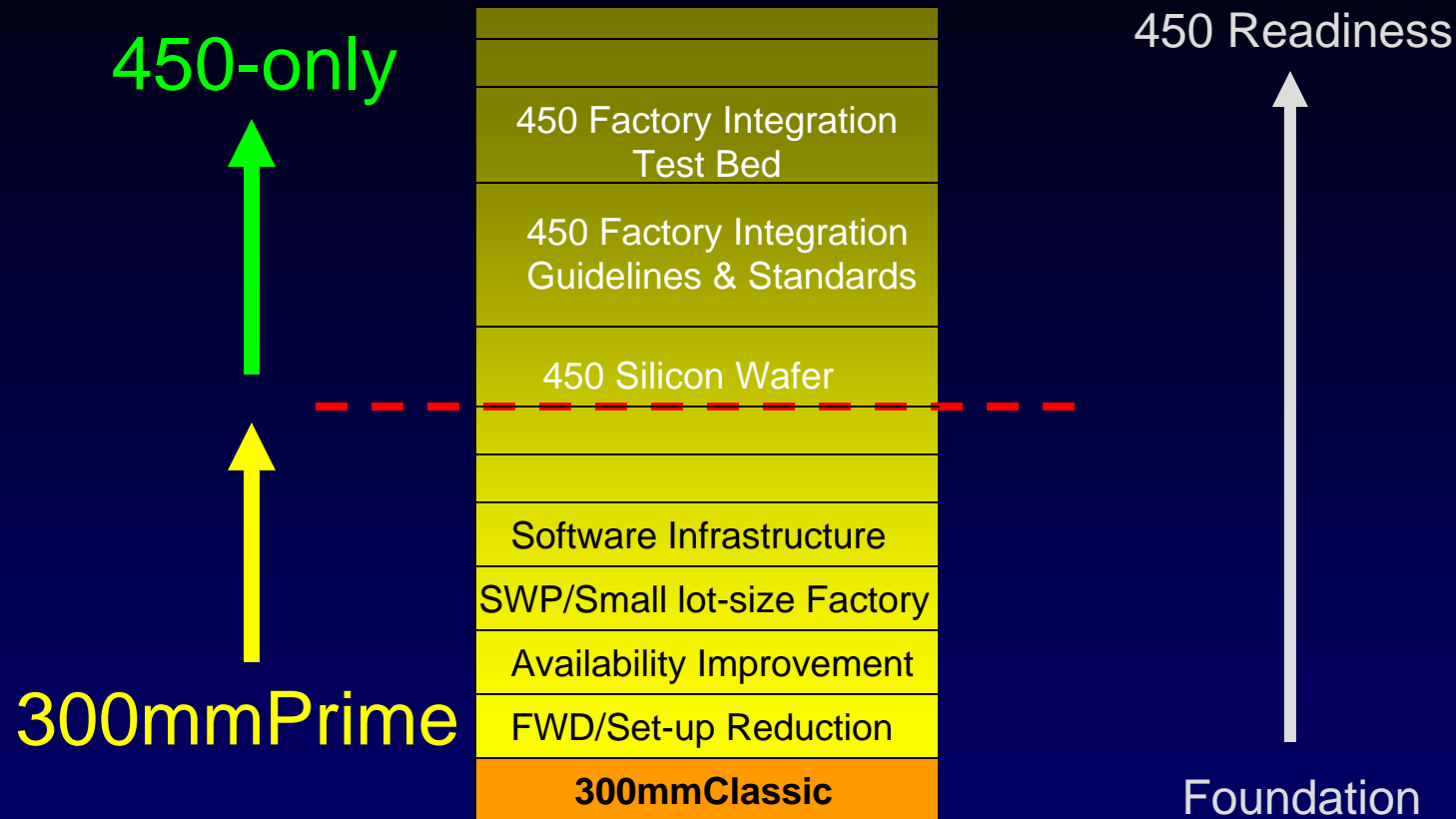
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ISMI Perspective on 450mm

- ISMI will initiate a 450mm Program dedicated to moving ahead with 450mm industry capability.
 - New mission
 - New structure
- ISMI plans to pursue in 2008:
 - Availability of 450mm silicon wafers
 - 450mm Factory Integration Guidelines & Standards
 - Creation of a 450mm Factory Integration Test Bed
 - Interoperability testing of prototype automation and equipment interfaces

Next Generation Factory Vision Realization



- ISMI is moving forward with both complementary forward-compatible paths for 300mmPrime as well as 300mm continuous improvement projects
- **Collaboration is a critical success factor: Inside and Outside ISMI**

450mm Program Structure for 2008

450mm Transition Program (Exclusive 450mm Focus)

Si Wafer Readiness

Factory Integration Guidelines and Standards

Factory Integration Interoperability Test Bed

450mm Transition Program

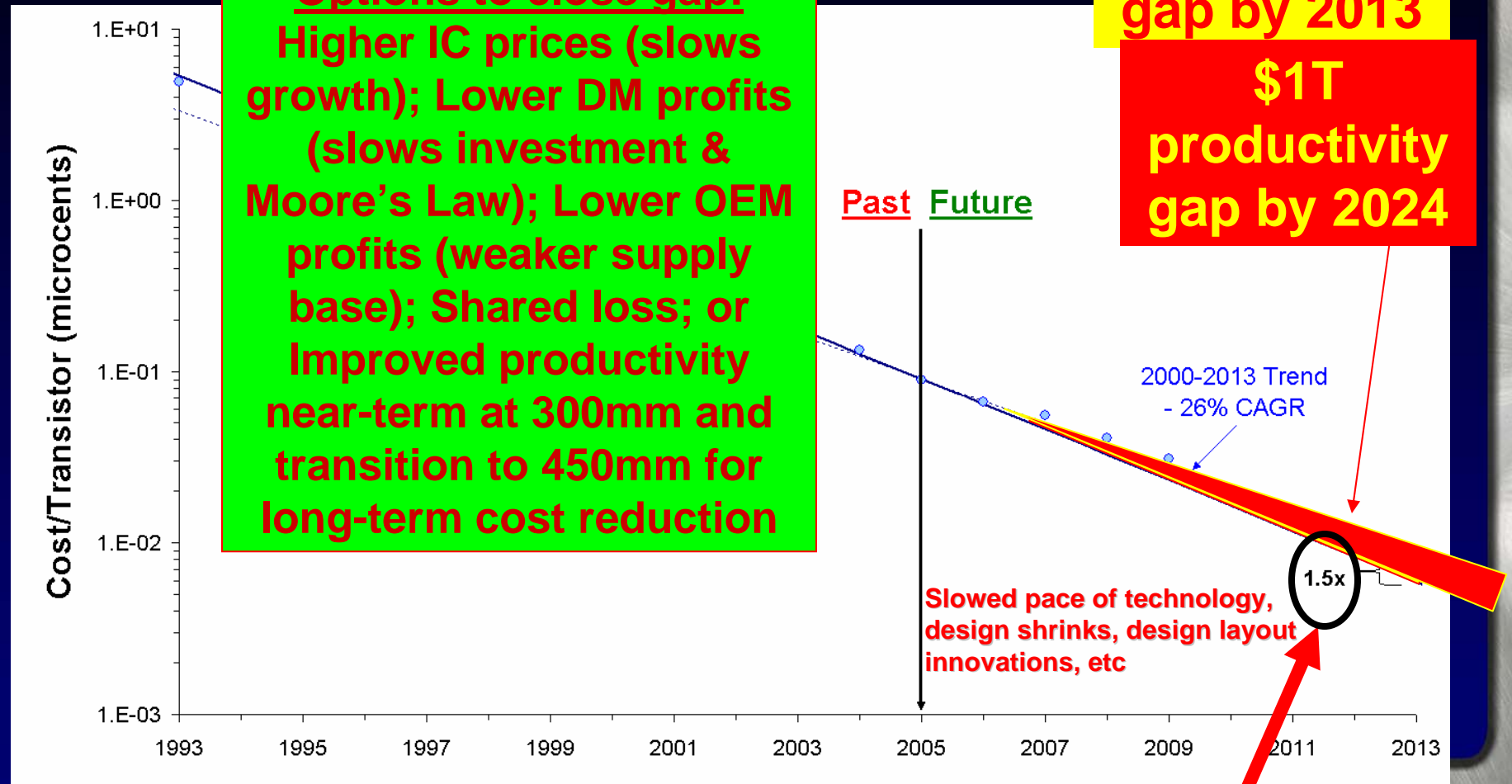
**2008
Objective:**

Coordination and support of 450mm transition projects and strategic industry activities

Goals

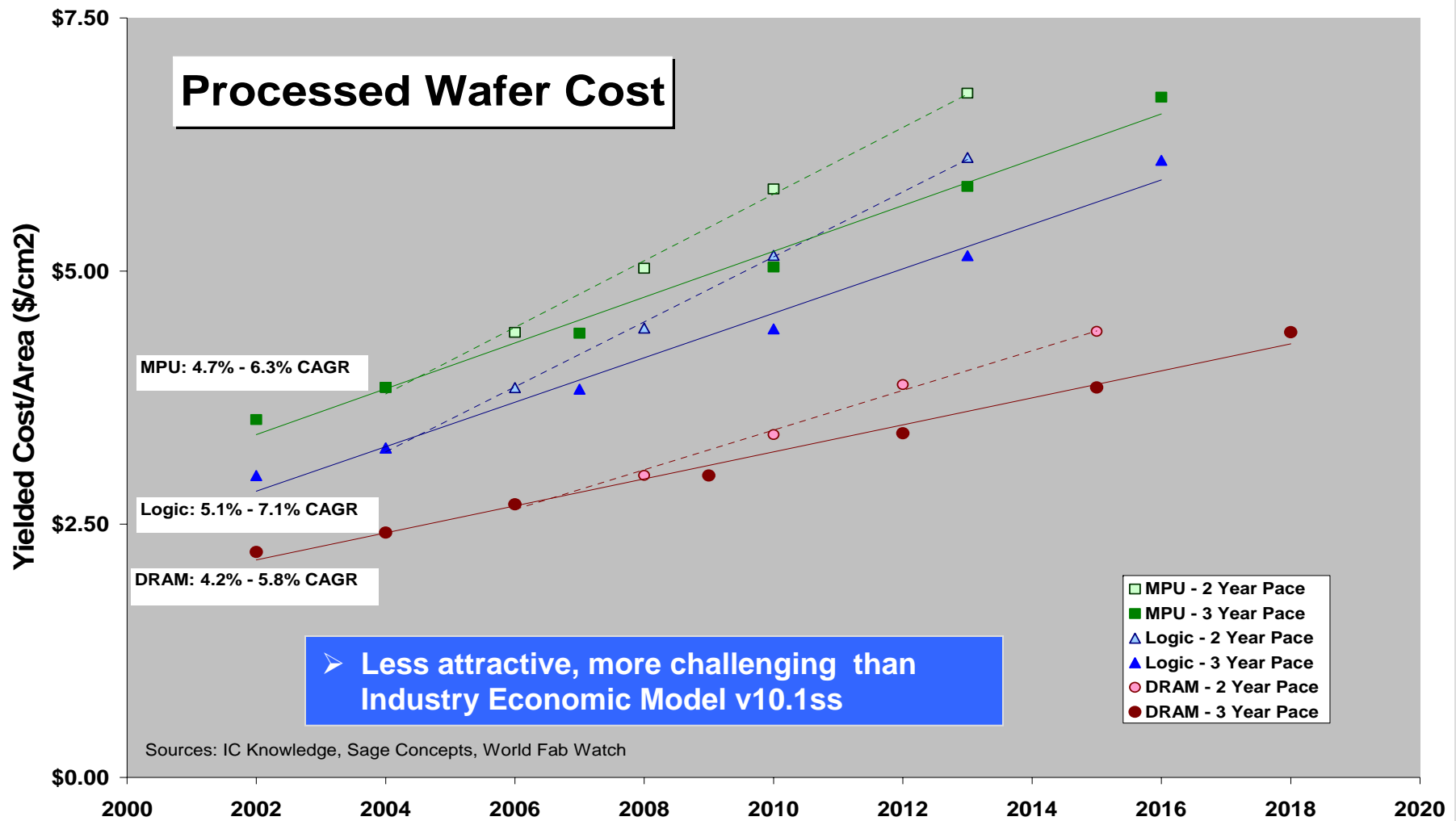
- Complementary forward-compatible approach for 300mm Prime and 450mm
- Timely and open communication with suppliers and at industry forums
- Active supplier engagement with ISMI (Test Bed, silicon readiness, guidelines)
- Coordinated industry standards activities (SEMI MTF, PEA, standards, ESG, etc.)
- Ongoing economic monitoring responsive to changing industry dynamics for 450mm
- Clear understanding of 450mm EHS challenges

Productivity Gap



50% increase in cost/transistor by 2013

Industry Wafer Cost Trends



2002-2012/13 Cost Growth: MPU +65–92%, DRAM +53-74%, Logic +73-105%

450 mm Silicon Wafer Readiness Project

2008 Objective: 450mm wafer availability to enable 450mm development

Goals

- Validation of 450mm handling wafer & process test grade wafer assumptions
- SEMI 450mm silicon handling wafer & process test grade wafer standards
- Assessment of technical feasibility, supplier commitment, and implementation plans for silicon, inspection and silicon manufacturing infrastructure
- A supply of functional 450mm silicon handling test wafers

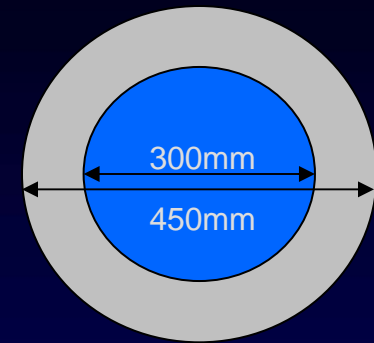
450 mm Handling Wafer Standardization

- Goal is to limit changes from 300mm wafer as much as possible
 - ❖ Thickness is a critical decision
 - ❖ Notch is likely for 450mm wafer
 - ❖ Wafer diameter tolerance may reduce
- 450mm wafer assumptions require validation and feasibility studies by silicon suppliers
- Edge profile may need to be standardized for 450mm
- Shippers/Carriers for 450mm wafers need to be standardized in the near term

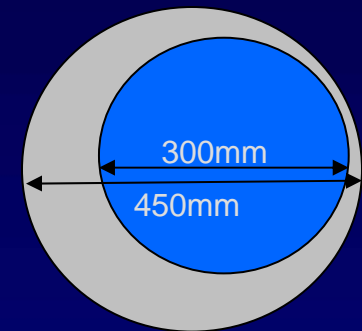
Sintered Wafer Strategy

- Sintered silicon ingots and wafers have been developed to jump start the 450mm manufacturing activities
 - Can reduce the silicon manufacturing learning curve
 - Can provide wafers with the mechanical and optical characteristics for wafer carrier, automation and OEM development work
- Hybrid test wafers will supply material for characterization equipment development and provide OEMs with preliminary wafers for process development
- Sintered and hybrid silicon wafers are not replacement of single crystal silicon wafers required in IC manufacturing.

Hybrid test wafers



concentric



eccentric

Wafer and Manufacturing Equipment Infrastructure Status

- The silicon suppliers infrastructure (pullers, crucibles, DSP polishers..) is moving toward 450mm support. The characterization equipment is still lagging behind.
- Mechanical test wafers (sintered) have been manufactured starting H2/06 and CZ single crystal pulling feasibility studies were completed.



450mm Factory Integration Guidelines and Standards

2008 Objective: *Timely creation of testable Next Generation Factory Architecture guidelines and standards to accelerate 450mm*

Goals

- “Rev. 2” level detail of the Unified Guidelines which comprehend and identify needed 450mm FI standards
 - e.g., Carriers, Shipping Boxes, Load Ports, Equipment Platforms, AMHS, etc.
- Defined tests and evaluation of early prototypes in support of ISMI 450mm Test Bed for interoperability and standards development
- Factory integration standards coordinated in timeframe required for 450mm early adopters

Guideline Development Approach

Motivation:

The current version of the 19 point guidelines have varying degrees of maturity/detail. Assessing current level of detail is a critical next step to enable suppliers to begin development and implementation of solutions

Approach:

1. Establish the current level of maturity/detail for each guideline
2. Define the required end-state level of detail for each guideline.
3. Prioritize guidelines via survey inputs to understand where to focus work
4. Qualitatively estimate scope/content for top priority guidelines

ISMI 450mm Guideline Development Priorities

- **Front-opening, 25 wafer, purge-able carriers (#'s1-3) are top priority for 450mm**
- **Elimination of First Wafer Delay (#12) is important and with high benefit**
- **300mm equipment improvements and learnings expected to be applicable to 450mm**

450 mm Factory Integration Test Bed Project

**2008
Objective:**

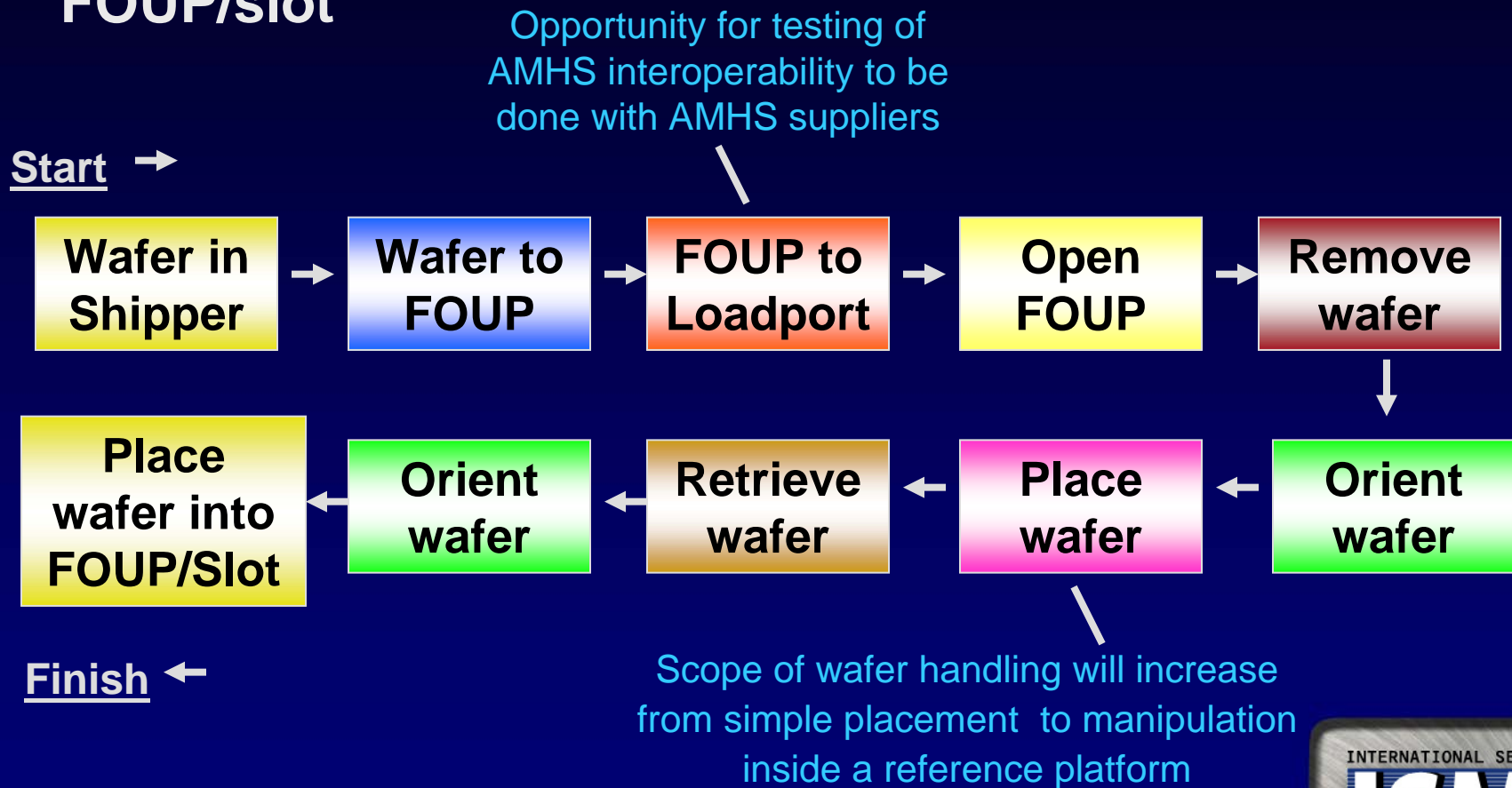
*Prototype Testing of 450mm Factory
Integration Interoperability Challenges*

Goals

- Prototype 450mm equipment developed for testing by Carrier, Loadport/EFEM, Equipment Mainframe, and AMHS suppliers
 - Equipment integrated and demonstrated/tested at ISMI facility
- Test plans defined, planned, and executed for key 450mm technical challenges
- Defined 450mm factory integration requirements supported by structured testing and evaluation
 - E.g., Carrier wafer support, wafer pitch, wafer handling, purging/sealing, reference platform interface standardization,, etc.
- Standards activities enabled by published low-level testing results and learnings

450mm FI Test Bed Approach

- Demonstrate and identify challenges moving silicon from shippers through an EFEM returning to a desired FOUP/slot



Suppliers are encouraged to participate in Test Bed activities

Summary

- ISMI has developed a complementary forward-compatible approach of 300mm to 450mm
 - Addresses the needs of our various member constituencies
 - Attempts to minimize the R&D expenditure by the industry
 - Efficient use of industry resources is key
- Implications to ISMI programs
 - **Initiate tangible 450mm activities to address long-term fundamental cost reduction**
 - *Cycle time also important for 450mm*
 - **Pursue 300mm improvements to enable significant near-term cycle time and cost reduction efforts**
 - **Initial 2008 activities efficiently guide two supplier groups**
 - **300mmPrime: Process & Metrology Equipment**
 - **450mm: Silicon & Factory Integration**

Next Steps for ISMI

- Meet with interested suppliers to discuss 300mm and 450mm implications & opportunities
- Continue to investigate small carrier size options and implications for Next Generation Fabs
- Continue development of Next Generation Factory Guidelines for more detailed level guidance & global perspective
- Update industry on detailed 2008 450mm plans at SEMICON Japan in Dec'07
- Increase synergy between 300mm & 450mm programs
 - Efficient use of industry resources is key
 - Complementary forward-compatible paths
- Proceed consistent with our principle that 300mm Prime is a productivity continuum to 450mm

For more Information...

This presentation material will be made available for download at the SEMATECH public website:
www.ismi.sematech.org

To initiate individual discussions with the ISMI Team, please contact:

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